

Notice of References Cited

Application/Control No.

10/762,931

Applicant(s)/Patent Under

Reexamination

HEINER ET AL.

Examiner

PAUL S. HYUN

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0067164 A1	04-2004	VanBrunt et al.	422/063
	B	US-			
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	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	WO 01/69210 A1	09-2001	Germany	Hartwich et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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